

Notice of References Cited	Application/Control No. 10/029,665	Applicant(s)/Patent Under Reexamination YOSHIZAWA ET AL.	
	Examiner BRIAN P. YENKE	Art Unit 2614	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,924,816	08-2005	Deering, Michael F.	345/589
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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